

High p_T b -tagging at CDF: Measuring Efficiency and Understanding Mistags

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- Outline:**
- **Challenge of b -tagging at a hadron machine**
 - **Lifetime-based b -tagging at CDF**
 - **Measuring efficiency in the data**
 - **Understanding contribution from non- b sources**
 - **Other CDF b -tagging techniques**
 - **Considerations for LHC experiments**
 - **Summary**



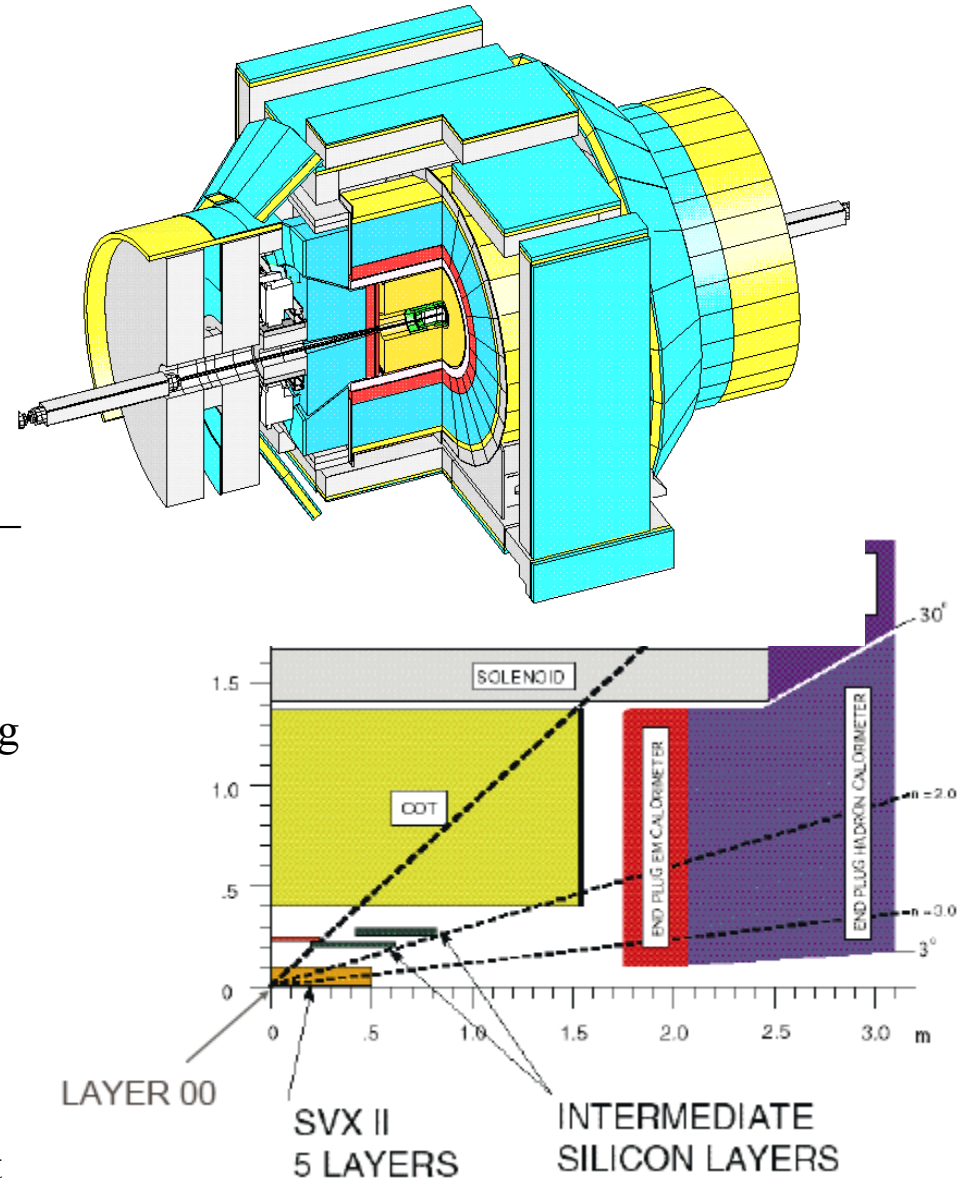
b-Tagging at the Tevatron

- The **ability to identify jets originating from *b* quark production** is critical for several facets of the Tevatron RunII physics program – top, Higgs, exotic searches, QCD...
- **Distinguishing jets from *b* quarks** from light flavor and charm:
 - The **long lifetime** of the *b*
 - The **large mass** of *B* hadrons
 - The **energetic semileptonic decay** of *B* hadrons
- Given that we have some nice handles – ***b*-tagging sounds easy, right?**
- **Challenges at a hadron machine:**
 - **Busy environment** in tracking detectors
 - **Multiple interactions** within each crossing
 - **No $Z \rightarrow bb$ peak** with which to calibrate tagging algorithms
 - Calibration samples are available – but **incomplete overlap** with interesting signal spectra
- **Challenges distinguishing bottom jets from charm jets:**
 - Charm has **nonzero lifetime**
 - **Intermediate mass** of charmed hadrons
 - **Similar semileptonic decay** spectrum to *B* sector



The CDF Detector: Crucial Components for Tagging

- **Charged particle tracking:**
 - **Solenoid provides a 1.4T magnetic field**
 - Good momentum resolution
 - **Silicon:** several subsystems
 - **SVXII:**
 - 5 layers out to radius of 10.6cm
 - $|z| < 45\text{cm}$
 - **L00:**
 - Directly on beampipe
 - Valuable for improved tracking – 4% increase in tag efficiency
 - **ISL:**
 - Two layers at $r = 20,28\text{cm}$
 - Provides forward silicon tracking
 - **COT:**
 - Open drift chamber
 - Good p_T , spatial resolution
- **Calorimetry** – jets, electrons
- **Muon system** - muons
- **Trigger**
 - Highly efficient for high p_T leptons
 - Also collects valuable inclusive lepton, jet samples



CDF b -tagging Tools

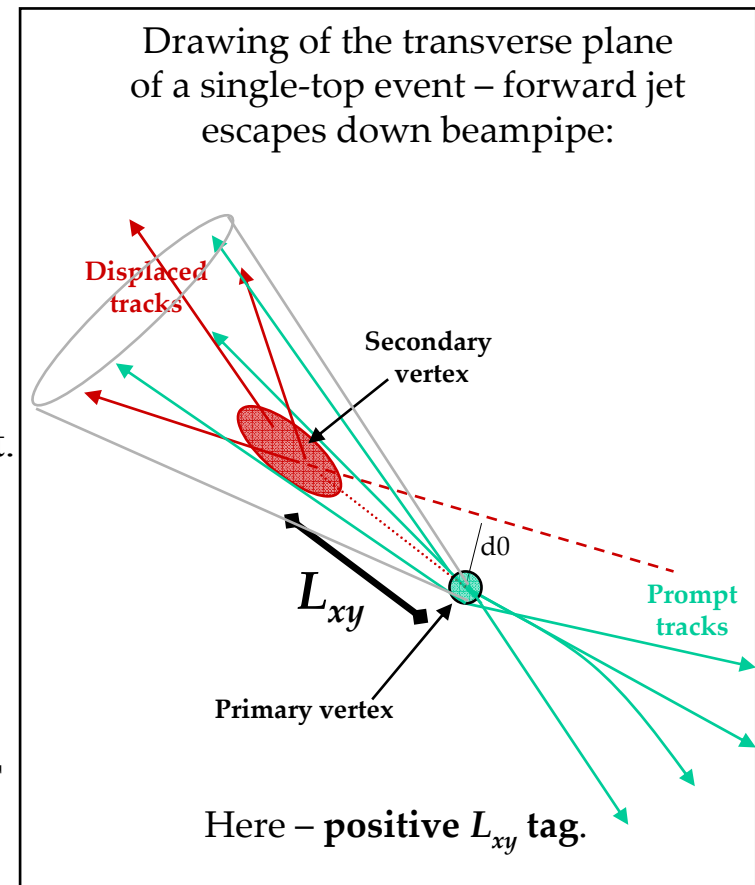
- **Ingredients for a useful tagger:**
 - **Tag efficiency for b -jets** in data, MC
 - **Mistag rate** in order to understand **contribution to tagged sample from non- b sources**
 - per-jet mistag probability
 - Efficiency and mistag probability are not single-valued
 - need to be examined as a function of jet- and event-level quantities
- CDF has **several tagging tools** in use/development for RunII analyses:
 - **Identification of jets with a secondary vertex – SECVTX:**
 - Exploits the long lifetime of the b quark
 - Additional handle one can use is the *mass of the reconstructed secondary vertex*
 - **Jet Probability:** incorporates lifetime, mass information
 - Assigns a per-jet probability that the jet was consistent with coming from a prompt source
 - **Soft lepton tagging:** looks for energetic electron or muon within a jet
 - **NN tagging algorithms:**
 - Simultaneous incorporation of lifetime, mass, semileptonic decay information along with event level quantities
 - Two versions under development
 - One that attempts to increase purity within SECVTX selected sample
 - Another that looks for tags in generic jet sample

Main focus of this talk



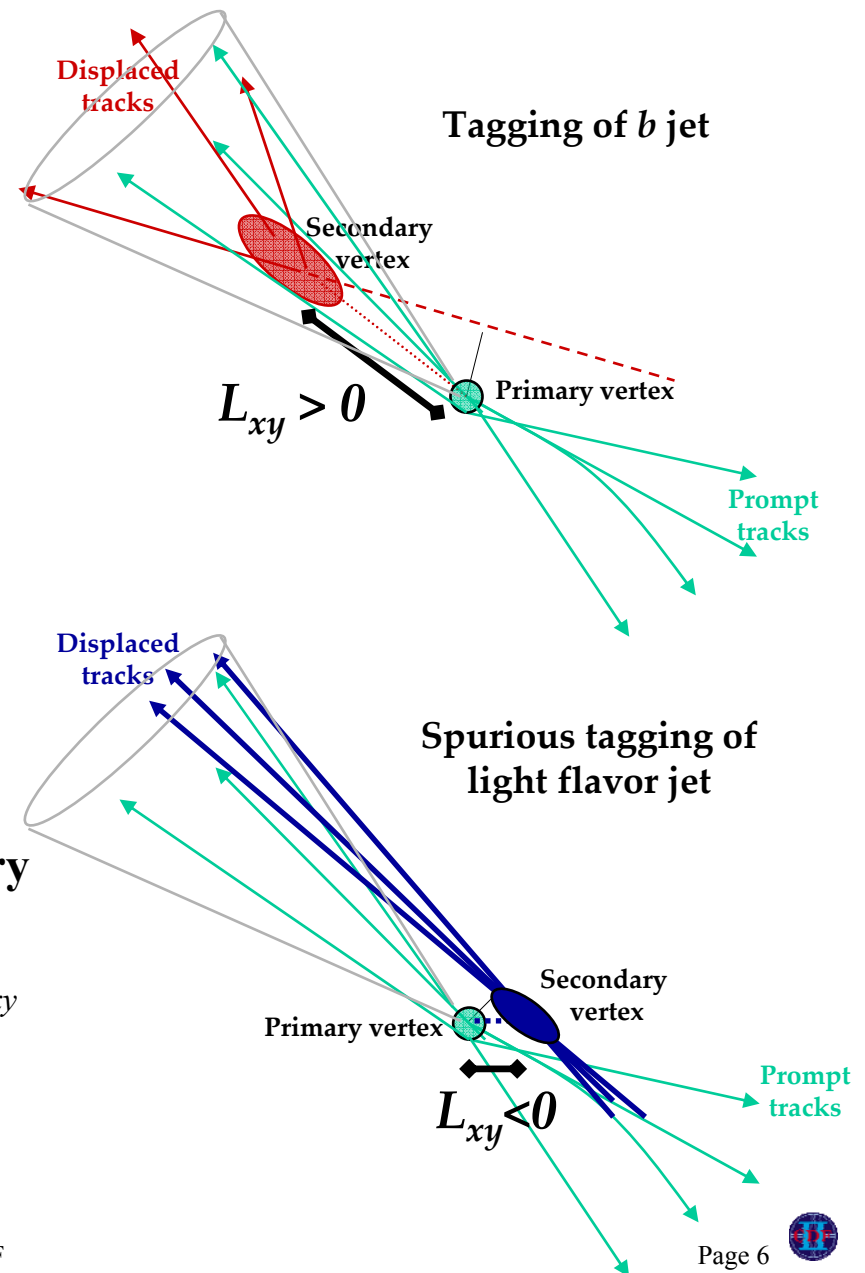
Secondary vertex b -tagging at CDF

- **SECVTX algorithm:** attempt to construct a secondary vertex among large impact parameter (d_0) tracks using a two-pass scheme
 - **Pass1:**
 - Starts with construction of **2-track “seed” vertex**
 - **Attach** all remaining tracks that are consistent with seed.
 - Construct the multitrack vertex, iteratively **pruning** away the attached tracks if they spoil vertex fit.
 - **Resulting candidate vertex required to have 3 or more tracks**
 - **Pass2:** tighter track d_0 significance requirement
 - Attempt to **vertex all** these tracks to a common point.
 - **Remove** any track that spoils the vertex fit, re-vertexing after each removal.
 - **Resulting candidate vertex required to have 2 or more tracks**
 - Apply **vertex quality cuts**
 - removal of K_s, A vertices
 - Removal of vertices in the **material portion of CDF** (beampipe, silicon ladders)
 - **If the vertex survives, the jet is “tagged”** –
 - **sign of transverse displacement** of secondary vertex wrt interaction point, L_{xy} , determines **positive tag** or **negative tag**.



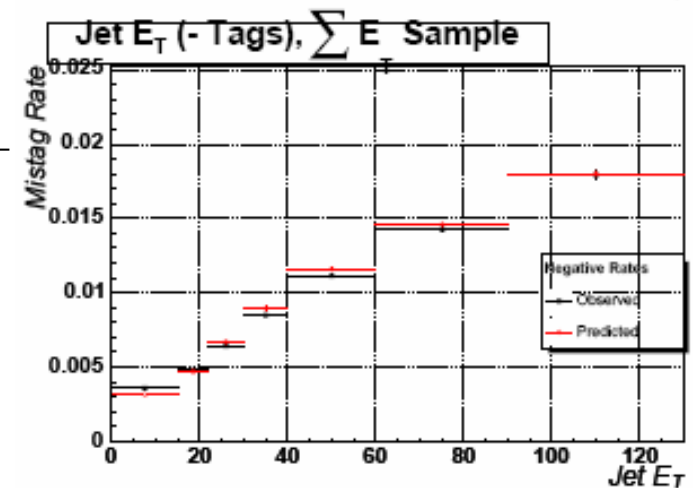
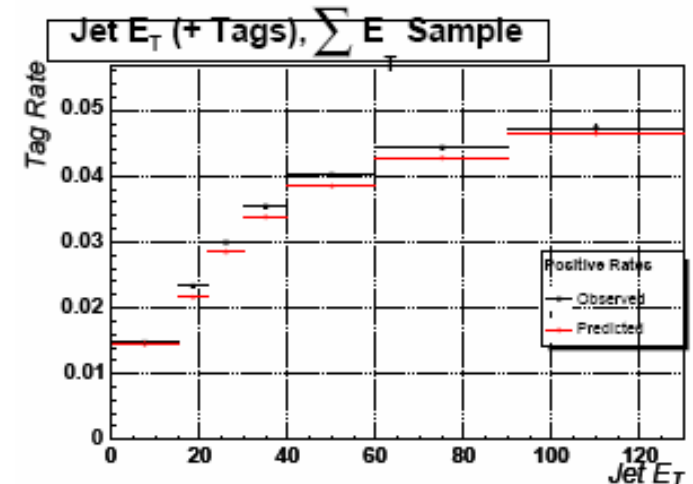
Contribution to b -Tag Sample from Light Flavor Jets

- The **flight direction** a B hadron travels in during its lifetime is **correlated to the jet direction**
- **Light flavor jets** should be consistent with **zero lifetime**
 - However **fake tracks within a jet** with large impact parameter can help satisfy vertex requirements
- **Sources of fake tracks:**
 - **Limited detector resolution**
 - **Long-lived light particle decays** (Λ , K_S)
 - **Material interactions**
- Fake tracks within a jet from limited detector resolution should be **symmetric about the primary interaction point**
 - Therefore light flavor vertices symmetric in L_{xy}
- This allows one to *use the ensemble of negatively tagged jets as a prediction to the light flavor contribution to the positive tag rate* (aka mistags)



Contribution to b -Tag Sample from Light Flavor Jets

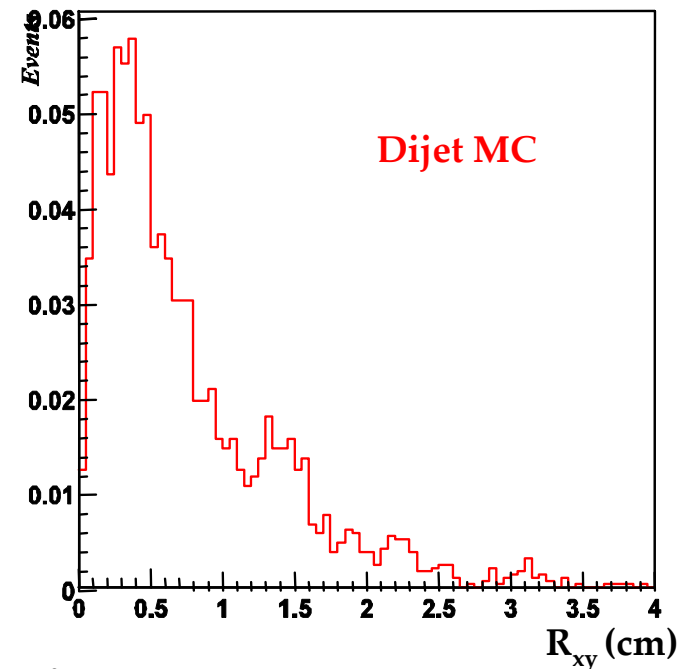
- However what is needed is an **a priori prediction of the light flavor content** of the positively tagged jets in the signal data sample
- **Procedure:**
 - For b -tagging based top physics analyses, the focus is the **W +jets data sample**
 - Use **inclusive jet sample for calibration** of mistags
 - Determine **per-jet mistag probability** in a number of different variables –
 - Jet E_T , $|\eta|$, ϕ
 - Jet track multiplicity
 - ΣE_T^{jets}
 - Use calibration jet samples to determine parameterization – then **apply to signal data sample**
- **Sources of systematic error:**
 - Extrapolation from calibration sample to signal sample
 - Uncertainty on ΣE_T^{jets}
 - Trigger bias
- Result: can predict **mistag contribution to 8%**



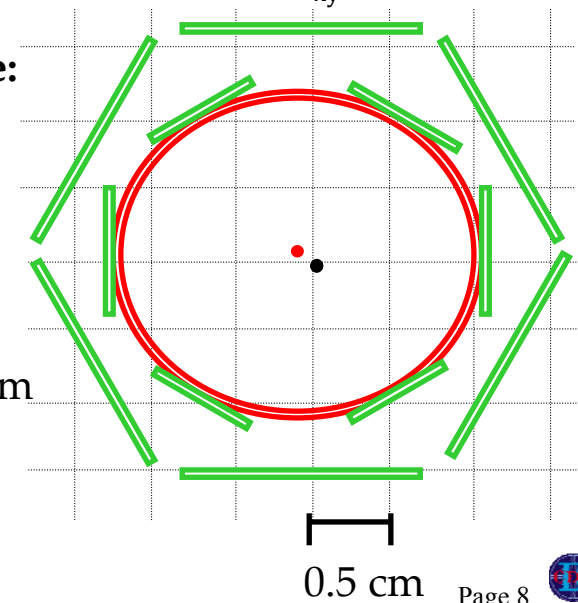
Light Flavor Jet Tag Asymmetry

- The **mistag parameterization** only accounts for limited detector resolution source of the mistag sample
- Material interactions within the jet decay bias the distribution to positive L_{xy} values – introducing a **light flavor jet tag asymmetry**
- Asymmetry can be measured
 - MC templates of pseudo- $c\tau$ for b , c , and light flavor jets
 - Fit to pseudo- $c\tau$ distribution from generic jet sample

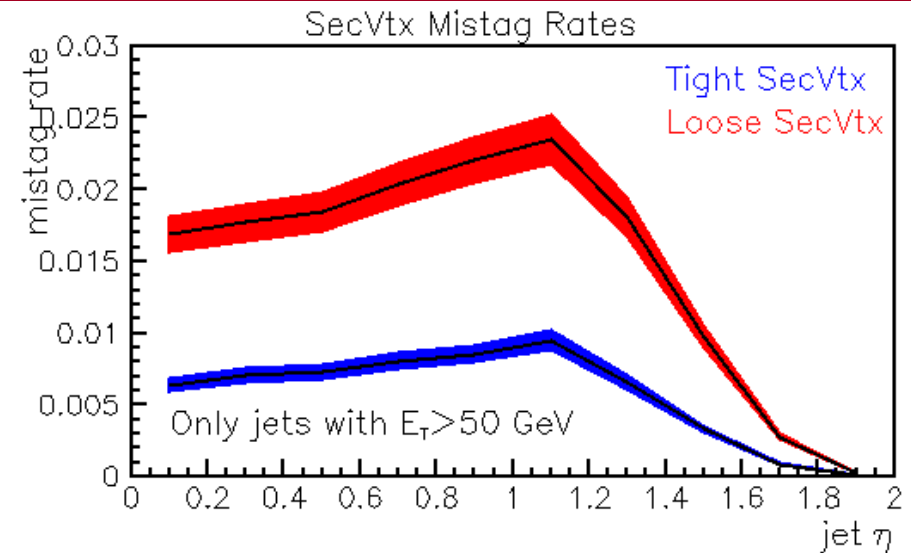
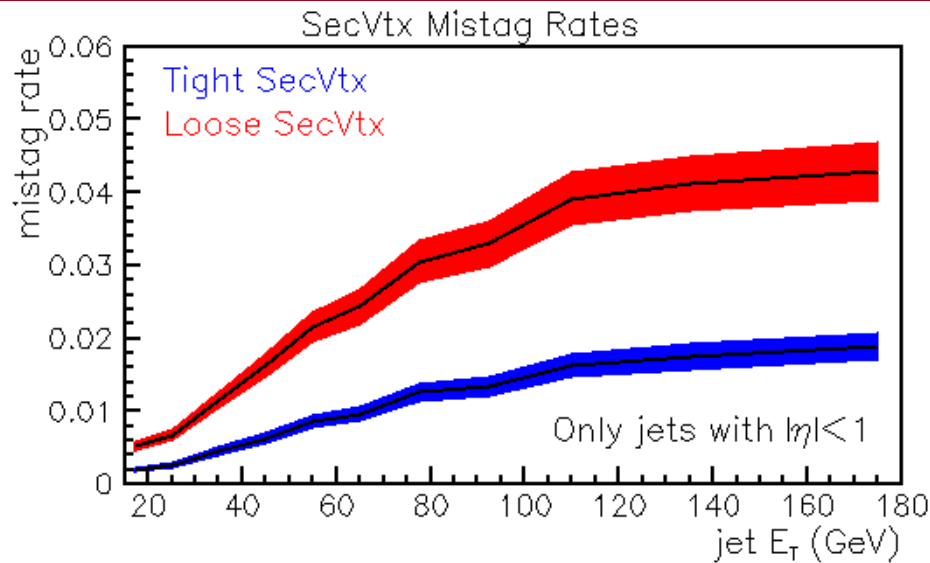
$$N_{\text{light}}^+ / N^- = 1.27 \pm 0.13$$



- - Center of COT
- - Center of Beampipe:
 - $\delta x = -0.11\text{cm}$
 - $\delta y = 0.15\text{cm}$
- ▭ - Beampipe:
 - $r = 1.26\text{cm}$
 - Thickness = 0.05cm



Summary: Mistags



- **Mistag studies:**
 - Data from inclusive jet samples
 - Two SECVTX operating points – **Tight and Loose**
 - Different points in **efficiency-versus-purity space**
- **Loose operating point** is similar to proposed LHC taggers
 - Relaxed track requirements wrt Tight SECVTX – larger mistags
 - For a **central $E_T = 40$ GeV jet**, the SECVTX mistag rate is **$\sim 1\%$**

Efficiency Measurement in the Data

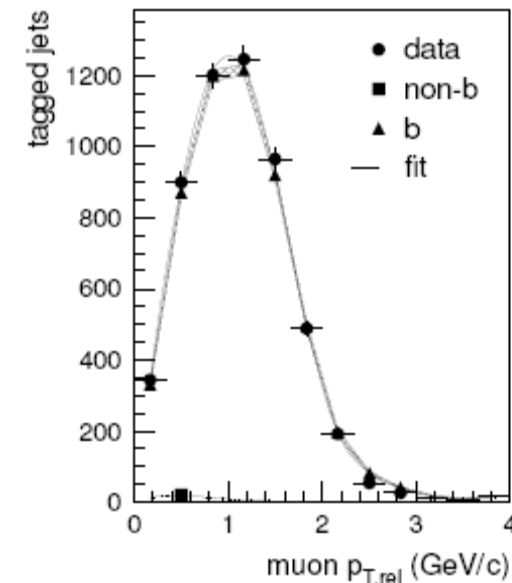
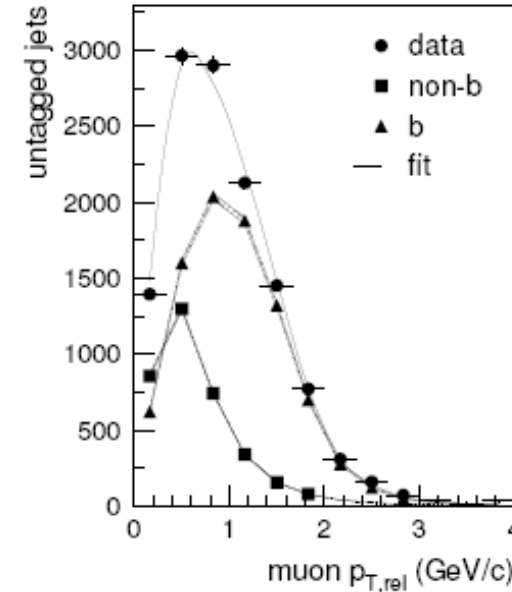
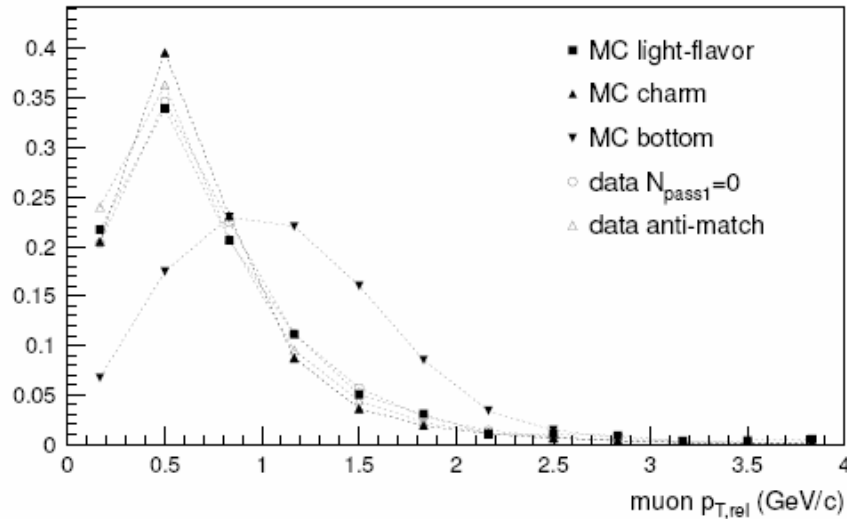
- **Understanding the tag efficiency in the Monte Carlo is simple**
- But what one really seeks is **the efficiency for tagging b-jets in the data**

- **Strategy:**
 - Measure the tag efficiency in data in a sample that is enriched in real b-jets
 - Measure the tag efficiency in MC in a sample that models this HF-enriched data sample
 - Calculate a ***b*-tagging scale factor** = Ratio of data tag efficiency / MC tag efficiency
 - Scale factor is a measure of how the MC differs from reality

- **Two techniques currently employed at CDF:**
 - Both use samples of dijets
 - Enrich the HF content:
 - One jet demanded to have a lepton – so-called “lepton-jet” – indicative of semileptonic B decay
 - Other jet – recoil or “away-jet” – demanded to be tagged
 - One method relies on “**muon-jets**” and fits the b- and non-b content using **templates of the relative p_T of the muon wrt jet axis = p_T^{rel}**
 - One method considers **double tags** in events where the away jet is paired with an “**electron-jet**” that is also tagged



b -Tag Efficiency: Muon p_T^{rel} Method



- p_T^{rel} templates drawn from MC
 - Charm template very similar to that of light-flavor jets
 - b template similar for tagged and untagged b -jets
- Used to fit for b and non- b content in untagged and tagged data sample

Statistical errors only

Pretag b -fraction	$0.779 \pm 0.009 \pm 0.015$
Tagged b -fraction	$0.990 \pm 0.016 \pm 0.002$
Data tag efficiency	$0.392 \pm 0.007 \pm 0.008$
MC tag efficiency	0.4278 ± 0.0019

- Systematic errors: main source is **extrapolation to higher jet E_T**
- Result: **SF = $0.915 \pm 0.017(\text{stat}) \pm 0.060(\text{sys})$**



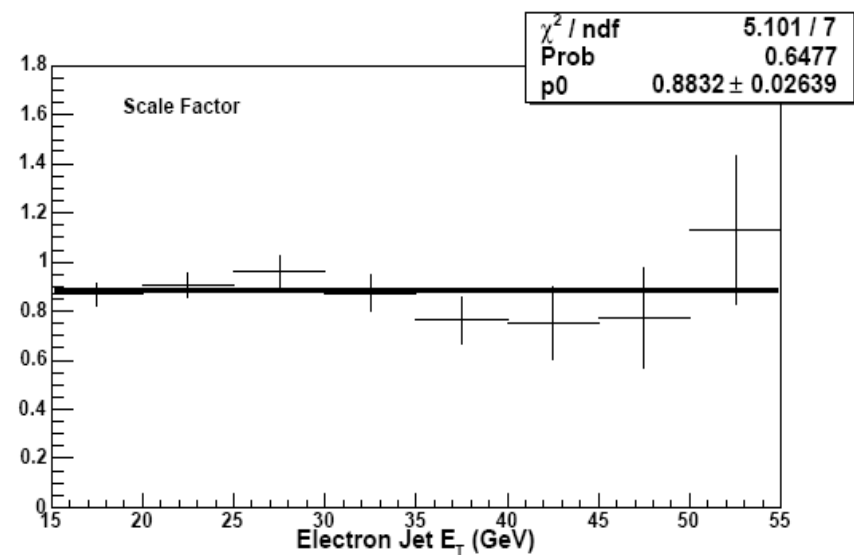
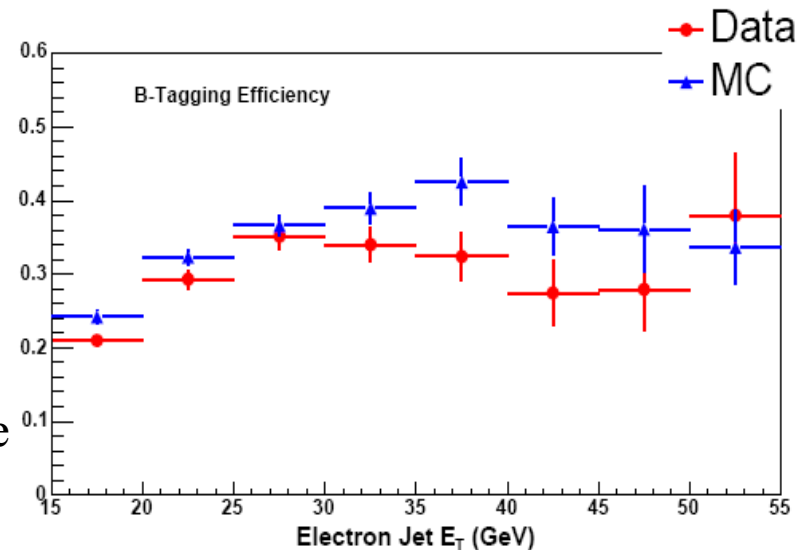
b-Tag Efficiency: Electron Method and Comparison

- HF-enriched electron-jet sample contains both semileptonic B decays and conversions
 - Use single tag rate in electron jet to **algebraically solve** for HF content of untagged sample
 - **Conversions** provide a complementary sample with similar topology with which one can understand the real HF content of the away-jet tagged sample

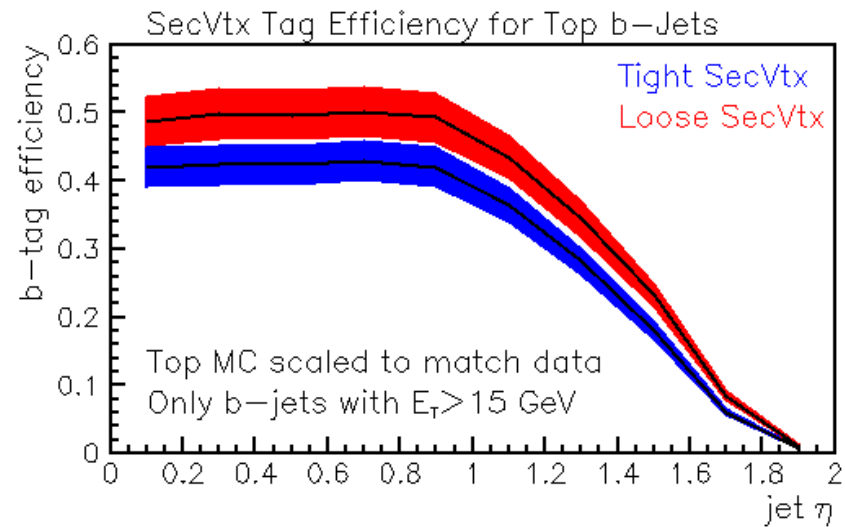
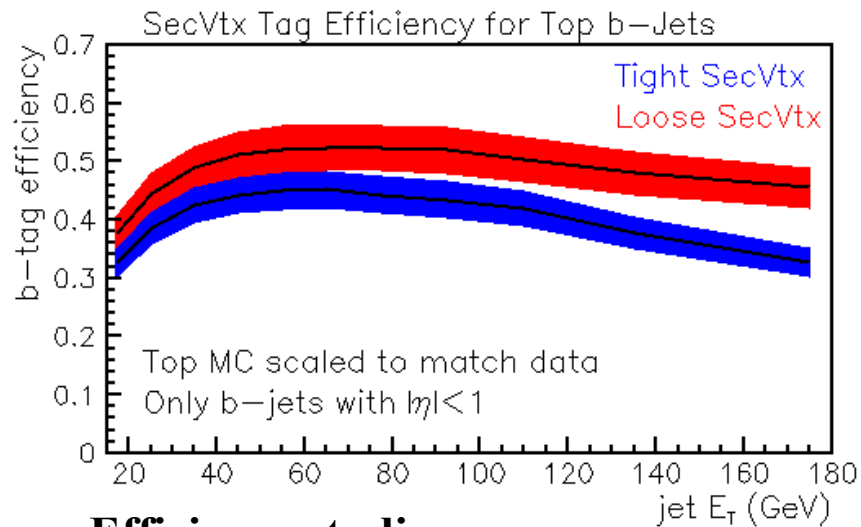
- Main sources of systematic error: **extrapolation** to higher jet E_T , ***b,c* fraction** in electron jets
- Result: **SF = 0.890 ± 0.028(stat) ± 0.072(sys)**

- Combination of electron and muon methods:

$$\text{SF}_{\text{combined}} = 0.909 \pm 0.060(\text{stat+sys})$$



Summary: Efficiency

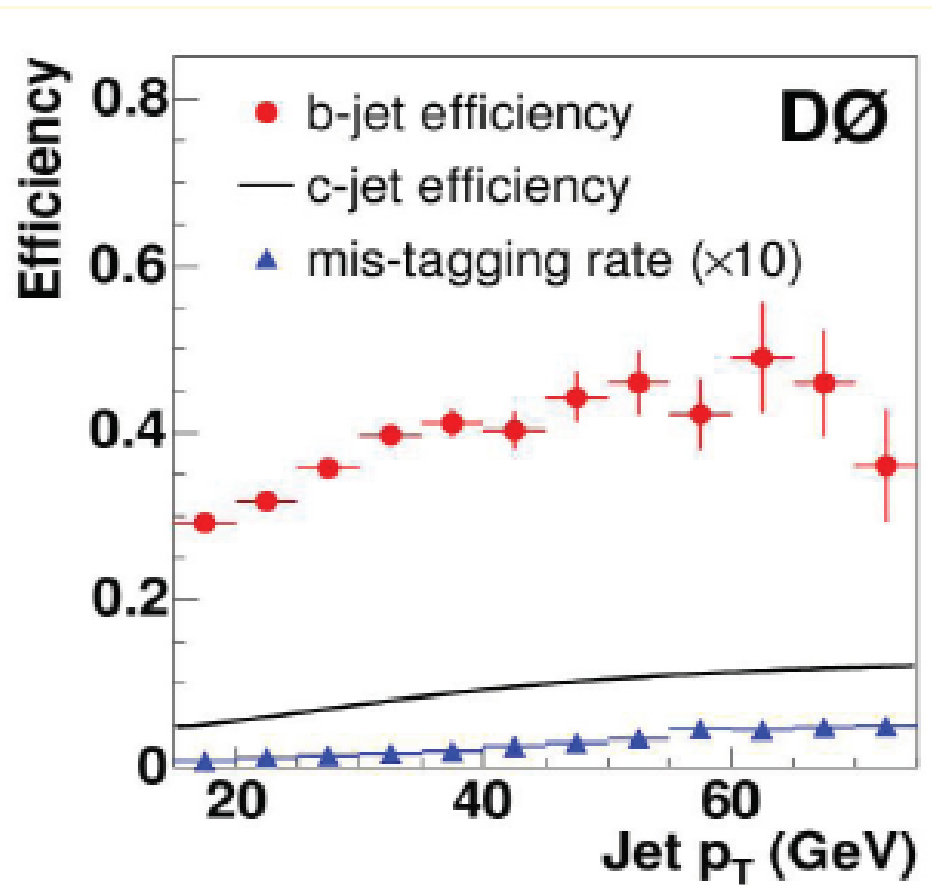


- **Efficiency studies:**
 - ttbar Pythia MC studies
 - b -tagging SF has been applied
- **Loose SECVTX operating point** – used in several top complete/ongoing top analyses
 - For a central $E_T = 60$ GeV b-jet in top decay, the Loose SECVTX tag efficiency is **~52%**
 - **Efficiency decrease at large $|\eta|$** is due mostly to tracking efficiency in the forward region – which are currently seeking to improve
- **Charm efficiency:**
 - Measured in MC, similar SF
 - Efficiency ranges from 5-10% as a function of jet E_T



b-Tagging at D0

- **D0 in RunII also has secondary vertex *b*-tagging in RunII**
- **Benchmarks:**
 - Efficiency for a 60 GeV *b*-jet is $\sim 45\%$
 - Mistag rate for 40 GeV jet is $\sim 0.3\%$
- This is best compared to the CDF **SECVTX Tight operating point:**
 - CDF Tight SECVTX efficiency for a 60 GeV *b*-jet is $\sim 45\%$
 - CDF Tight SECVTX mistag rate for 40 GeV jet is $\sim 0.4\%$ for central jets –



CDF and D0 tagging algorithms have similar efficiency and mistag rates.



Looking Ahead to b -Tagging at LHC Experiments

- **Good amount of experience** has been gained at the Tevatron experiments
- Fairly successful b -tagging tools have been developed
- **This is not to mean however that all the problems are easy to solve**
- There are **many issues that deserve attention** for the future experiments:
 - **Alignment** of the silicon tracking detector
 - Understanding of the **charge deposition models** for particles as they traverse the silicon detector
 - Understanding the **material content around the interaction point**
 - **Tracking simulation** and its relation to reality
 - **Trigger effects** – ensure that enough calibration data is collected at appropriate ET , η range for the physics one wants to do



Summary

- Several critical portions of the Tevatron RunII physics program rely on the ability to identify jets originating from b quark production
- CDF has several b -tagging tools in use, including the secondary vertex tagger discussed here in particular
- With any b -tagging tool it is important to understand and quantify
 - Efficiency for tagging b -jets in the data
 - The rate at which non- b jets are tagged
- CDF has made progress in understanding these issues
- Tagger development for the LHC experiments can build upon the knowledge we have developed at the Tevatron



Backup

Backup – Muon Method Jet ET Dependence

